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IN THE CLAIMS

1. (Currently Amended) A method of designing a semiconductor integrated circuit, comprising the steps of: dividing a chip of a semiconductor integrated circuit into a number of areas and providing a plurality of clock pins for each of the areas;

performing distribution of a clock signal from a clock source pin to each of the areas in a transmission form that is of high-speed and resistant to noise; and

performing adjustment of a clock timing for each flip-flop in the semiconductor integrated circuit such that flip-flop-to-flip-flop data transmission can be performed in a target machine cycle,

wherein a plurality of kinds of methods having different adjustable ranges are used as methods of adjusting timing of the clock signal input to said flip-flop, [[and]] the flip-flops are grouped for each clock timing required by each flip-flop in said area, and each group of said flip-flops grouped for each clock timing is connected to a separate clock pin and adjusted in each clock timing required by each flip-flop ~~said grouped flip flops are adjusted in clock timing in accordance with requirement of each flip flop and connected to separate clock pins.~~

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2. (Original) The method of designing a semiconductor integrated circuit according to claim 1, wherein in using a method of adjusting clock timing by extending wiring length, a limit is provided for the wiring length.

3. (Currently amended) The method of designing a semiconductor integrated circuit according to claim 2, wherein said method of designing is combined with another different method of adjusting timing.

4. (Currently Amended) The method of designing a semiconductor integrated circuit according to claim 1, wherein ~~said method provides the clock timing of each flip-flop flip-flop, and extracts a closed loop consisting of a plurality of signal propagation paths according to maximum delay time, minimum delay time and the target machine cycle required for data transmission along each flip-flop-to-flip-flop signal propagation path, and with respect to each flip-flop in said closed loop, selects a clock timing of each flip-flop from among clock timing timings that can be adopted by said each flip-flop can adopt such so that data transmission can be performed in said target machine cycle and in a cycle number~~

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required for data transmission along said closed loop.

5. (Canceled).

6. (Previously presented) The method of designing a semiconductor integrated circuit according to claim 4, wherein said method extracts a signal propagation path or a closed loop along which flip-flop-to-flip-flop data transmission is not performed in said target machine cycle by the adjusting of said clock timing, and when a maximum delay time required for data transmission along the signal propagation path or the closed loop thus extracted is larger than a product of said target machine cycle and said cycle number required for data transmission along said closed loop, performs modification as so to shorten the maximum delay time required for data transmission along the signal propagation path or the closed loop thus extracted, while when a minimum delay time required for data transmission along the signal propagation path or the closed loop thus extracted is smaller than a product of said target machine cycle and a value smaller by one than said cycle number required for data transmission along said closed loop, performs modification so as to elongate the maximum delay time required for data transmission along the signal

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propagation path or the closed loop thus extracted.

7. (Currently amended) The method of designing a semiconductor integrated circuit according to claim 4, wherein ~~said method determines the clock timing of each flip-flop is determined~~ while gradually decreasing said target machine cycle, thereby determining a feasible minimum machine cycle.

8. (Canceled).

9. (Currently Amended) A method of designing a semiconductor integrated circuit, comprising the steps of:

providing an information file 1 including layout position information of cells, terminal-to-terminal connection relation information of cells, and wiring pattern information; [,] an information file 2 including clock delay designation information; [,] an information file 3 including delay calculation information for calculating delay of paths; [,] an information file 4 including clock-delay-adjusting methods, fluctuation values of clock delay caused by the adjusting methods, and clock-delay-adjusting costs by the adjusting methods; [,] and target machine cycles (MC) being changeable for each execution of the providing step;

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inputting information of said information files 1, 2, 3, and 4 and said target machine cycles (MC);

determining maximum delay time (DMAX) and minimum delay time (DMIN) required for data transmission along all flip-flop-to-flip-flop signal propagation paths;

determining a clock delay adjustable range from the clock delay designation information input and the clock-delay-adjusting methods being adopted by each flip-flop in said information file 4;

selecting one path, extracting a closed loop returning from the end point flip-flop to the starting point flip-flop of the selected path, and determining the total delay (DLY) of delay in each path in the closed path and a cycle number (CYC) required for data transmission along the closed loop; and

judging whether data transmission along said closed loop is possible in the target machine cycle or not, and if the judgement is NO, displaying information of the paths in the closed loop judged as the NO.

10. (Canceled).

11. (Original) The method of designing a semiconductor integrated circuit according to claim 9, further comprising

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the step of:

performing logic modification or packaging modification based on the information of a path in said displayed closed loop; and

feeding back the modification results to said information file 1.

12. (Currently amended) A method of designing a semiconductor integrated circuit, comprising the steps of:

providing an information file 1 including layout position information of cells, terminal-to-terminal connection relation information of cells, and wiring pattern information; [,] an information file 2 including clock delay designation information; [,] an information file 3 including delay calculation information for calculating delay of paths; [,] an information file 4 including clock-delay-adjusting methods, fluctuation values of clock delay caused by the adjusting methods, and clock-delay-adjusting costs by the adjusting methods; [,] and a memory including target machine cycles (MC) ;

inputting information of said information files 1, 2, 3, and 4 and said memory;

determining maximum delay time (DMAX) and minimum delay

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time (DMIN) required for data transmission along all flip-flop-to-flip-flop signal propagation paths;

determining a clock delay adjustable range from the clock delay designation information input and the clock-delay-adjusting method being adopted by each flip-flop in said information file 4;

selecting one path, extracting a closed loop returning from the end point flip-flop to the starting point flip-flop of the selected path, and determining the total delay (DLY) in each path in the closed loop and a cycle number (CYC) required for data transmission along the closed loop; and

judging whether the data transmission along said closed loop is possible in the target machine cycle or not, and if the judgement is YES, setting a clock-delay-adjusting range permitting data transmission to each flip-flop so as to satisfy a predetermined restraint for each path.

13. (Previously presented) The method of designing a semiconductor integrated circuit according to claim 12,

wherein the step of setting said clock-delay-adjusting range satisfies the following restraints for each path, and sets the clock-delay-adjusting range of each flip-flop within said determined clock delay adjustable range of each flip-

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flop.

MC × CYC (PATH) - CLK (S.FF) MAX + CLK (E.FF) MIN > DMAX

MC × (CYC (PATH) - 1) - CLK (S.FF) MIN + CLK (E.FF) MAX <
DMIN,

wherein

MC: target machine cycles per a second,

CYC (PATH): the cycle number required for data
transmission along the path concerned,CLK (S.FF) MIN, CLK (S.FF) MAX: a minimum value and a
maximum value of the clock-delay-adjusting range of the
starting point flip-flop, respectively, andCLK (E.FF) MIN, CLK (E.FF) MAX: a maximum value and a
maximum value of the clock-delay-adjusting range of the end
point flip-flop, respectively.

14-15. (Canceled).